


<b>Search Notes</b>  	<b>Application/Control No.</b>  10780500	<b>Applicant(s)/Patent Under Reexamination</b>  OH, BYONG MOK
	<b>Examiner</b>  Murdoch, Crystal	<b>Art Unit</b>  2628

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search	11/25/2007	CM
East Search	11/25/2007	CM
ACM ((panoramic and mosaic and "environment map") and (3D or "or" or "three dimensional"))	6/23/2008	CM
Updated EAST Search	7/2/2008	CM
Updated EAST Search	2/2/2009	CM
PLUS Search	1/23/2009	CM
Updated EAST Search	11/10/2009	CM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/Crystal Murdoch/ Examiner.Art Unit 2628	
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